



EIC Fellow

John Yeow

Nominated by IEEE Canada

John Yeow's contributions fall under the general umbrella of microsystems and nano devices for medical diagnostic and therapeutic instruments. His work has had a broad and seminal impact - from the advancement of scientific knowledge to industrial innovation. He is an international leader and educator in the development of nanotechnology-based multimodality imaging systems involving x-rays, optical and ultrasound imaging technologies.

For his leadership and education in the development of nanotechnology-based multimodality imaging systems, we now pay tribute to John Yeow with this honor.

Ladies & gentlemen and Mr. President, please welcome John Yeow as a Fellow of the Engineering Institute of Canada.